


<b>Search Notes</b>  	<b>Application/Control No.</b>  10589049	<b>Applicant(s)/Patent Under Reexamination</b>  URTEL ET AL.
	<b>Examiner</b>  Loewe, Sun Jae Y	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
keyword search in file CAPLUS in STN; search in file	6/3/2008	KP
keyword search in EAST (USPGPUB, USPAT, EPO, JPO, DERWENT, USOCR, FPRS); search in file	6/3/2008	KP
inventor search in EDAN, PALM and EAST (USPGPUB and USPAT); EAST serch in file	6/3/2008	KP
inventor npl search in file CAPLUS in STN; search in file	6/3/2008	KP
reviewed search report of counterpart PCT application	6/3/2008	KP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner